

S-19117/19119xxxH Series

AUTOMOTIVE, 105°C OPERATION, 36 V, SUPPLY VOLTAGE DIVIDED OUTPUT, VOLTAGE DETECTOR WITH SENSE PIN REVERSE CONNECTION PROTECTION

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Rev.1.1 00

This IC, developed using CMOS technology, is a high-accuracy voltage detector with the supply voltage divided output. The detection voltage and release voltage are fixed internally with an accuracy of $\pm 1.5\%$.

Apart from the power supply pin, the detection voltage input pin (SENSE pin) is also prepared, so the output is stable even if the SENSE pin voltage (V_{SENSE}) falls to 0 V. The SENSE pin also has a built-in reverse connection protection circuit that reduces current in the SENSE pin during a reverse connection.

The release signal can be delayed by setting a capacitor externally, and the release delay time accuracy is $\pm 15\%$ (C_D = 3.3 nF). The output form is Nch open-drain output.

The supply voltage divided output is prepared in this IC. The supply voltage divided output is a function that divides the V_{SENSE} into V_{SENSE}/6, V_{SENSE}/8, V_{SENSE}/12 or V_{SENSE}/14 and outputs the voltage. For example, this function makes it possible that the IC connects to a low voltage microcontroller A/D converter directly and the microcontroller monitors a battery voltage.

ABLIC Inc. offers FIT rate calculated based on actual customer usage conditions in order to support customer functional safety design.

For more information regarding our FIT rate calculation, contact our sales representatives.

Caution This product can be used in vehicle equipment and in-vehicle equipment. Before using the product for these purposes, it is imperative to contact our sales representatives.

Features

4.0 V to 10.0 V (0.05 V step	o)
±1.5%	
'Unavailable":	"Available": 5.0%, 10.0%
	"Unavailable": 0%
±15% (C _D = 3.3 nF)	
Nch open-drain output	
VPMOUT = VSENSE/6 (S-1911)	7 Series L / M / N type)
VPMOUT = VSENSE/8 (S-1911)	7 Series P / Q / R type)
VPMOUT = VSENSE/12 (S-191	19 Series L / M / N type)
VPMOUT = VSENSE/14 (S-191	19 Series P / Q / R type)
A ceramic capacitor can be	e used (0.1 μF to 0.22 μF).
Ensures long battery life.	
During supply voltage divid	ed output operates 1.15 μA typ.
During supply voltage divid	ed output stops 0.75 μA typ.
Reduces current in the SEN	NSE pin during a reverse connection.
3.0 V to 36.0 V	
Ta = -40°C to +105°C	
	±1.5% 'Unavailable": ±15% (C _D = 3.3 nF) Nch open-drain output V _{PMOUT} = V _{SENSE} /6 (S-1911) V _{PMOUT} = V _{SENSE} /12 (S-1911) V _{PMOUT} = V _{SENSE} /12 (S-1911) V _{PMOUT} = V _{SENSE} /14 (S-1911) A ceramic capacitor can be Ensures long battery life. During supply voltage divid During supply voltage divid Reduces current in the SEI 3.0 V to 36.0 V

AEC-Q100 qualified^{*1}

*1. Contact our sales representatives for details.

Applications

- Automotive battery voltage detection
- For automotive use (car body, headlight, ITS, accessory, car navigation system, car audio system, etc.)

Packages

- HTMSOP-8
- HSNT-8(2030)

Block Diagrams

1. S-19117/19119 Series L / P type

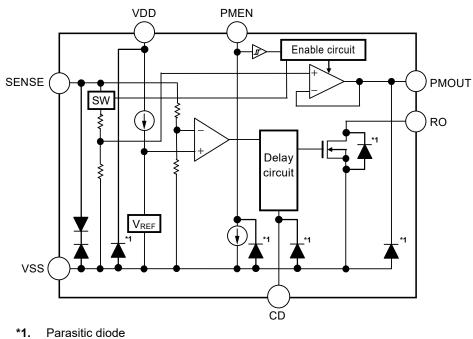


Figure 1

1.1 S-19117 Series

Table 1

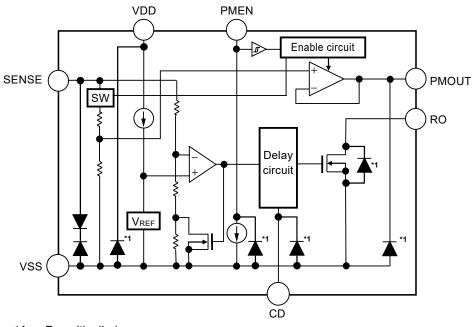
Product Type	Output Voltage of Supply Voltage Divider Block (VPMOUT)	Hysteresis Width	PMEN Pin Input Logic	RO Pin Output Form	RO Pin Output Logic
L type	Vsense/6	0%	Active "H"	Nch open-drain output	Active "L"
P type	Vsense/8	0%	Active "H"	Nch open-drain output	Active "L"

1.2 S-19119 Series

Table 2

Product Type	Output Voltage of Supply Voltage Divider Block (VPMOUT)	Hysteresis Width	PMEN Pin Input Logic	RO Pin Output Form	RO Pin Output Logic
L type	Vsense/12	0%	Active "H"	Nch open-drain output	Active "L"
P type	V _{SENSE} /14	0%	Active "H"	Nch open-drain output	Active "L"

2. S-19117/19119 Series M / N / Q / R type



*1. Parasitic diode

Figure 2

2.1 S-19117 Series

Table 3

Product Type	Output Voltage of Supply Voltage Divider Block (V _{PMOUT})	Hysteresis Width	PMEN Pin Input Logic	RO Pin Output Form	RO Pin Output Logic
M type	V _{SENSE} /6	5.0%	Active "H"	Nch open-drain output	Active "L"
N type	V _{SENSE} /6	10.0%	Active "H"	Nch open-drain output	Active "L"
Q type	V _{SENSE} /8	5.0%	Active "H"	Nch open-drain output	Active "L"
R type	V _{SENSE} /8	10.0%	Active "H"	Nch open-drain output	Active "L"

2.2 S-19119 Series

Table 4

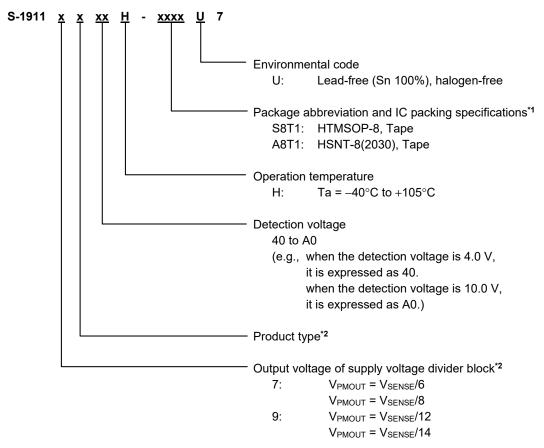
Product Type	Output Voltage of Supply Voltage Divider Block (V _{PMOUT})	Hysteresis Width	PMEN Pin Input Logic	RO Pin Output Form	RO Pin Output Logic
M type	V _{SENSE} /12	5.0%	Active "H"	Nch open-drain output	Active "L"
N type	V _{SENSE} /12	10.0%	Active "H"	Nch open-drain output	Active "L"
Q type	V _{SENSE} /14	5.0%	Active "H"	Nch open-drain output	Active "L"
R type	V _{SENSE} /14	10.0%	Active "H"	Nch open-drain output	Active "L"

■ AEC-Q100 Qualified

This IC supports AEC-Q100 for operation temperature grade 2. Contact our sales representatives for details of AEC-Q100 reliability specification.

Product Name Structure

1. Product name



- *1. Refer to the tape drawing.
- *2. Refer to "2. Function list of product types".

2. Function list of product types

2.1 S-19117 Series

Table 5

Product Type	Output Voltage of Supply Voltage Divider Block (VPMOUT)	Hysteresis Width	PMEN Pin Input Logic	RO Pin Output Form	RO Pin Output Logic
L type	VSENSE/6	0%	Active "H"	Nch open-drain output	Active "L"
M type	VSENSE/6	5.0%	Active "H"	Nch open-drain output	Active "L"
N type	VSENSE/6	10.0%	Active "H"	Nch open-drain output	Active "L"
P type	VSENSE/8	0%	Active "H"	Nch open-drain output	Active "L"
Q type	VSENSE/8	5.0%	Active "H"	Nch open-drain output	Active "L"
R type	VSENSE/8	10.0%	Active "H"	Nch open-drain output	Active "L"

2. 2 S-19119 Series

Table 6

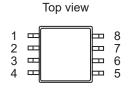
Product Type	Output Voltage of Supply Voltage Divider Block (VPMOUT)	Hysteresis Width	PMEN Pin Input Logic	RO Pin Output Form	RO Pin Output Logic
L type	Vsense/12	0%	Active "H"	Nch open-drain output	Active "L"
M type	V _{SENSE} /12	5.0%	Active "H"	Nch open-drain output	Active "L"
N type	V _{SENSE} /12	10.0%	Active "H"	Nch open-drain output	Active "L"
P type	V _{SENSE} /14	0%	Active "H"	Nch open-drain output	Active "L"
Q type	V _{SENSE} /14	5.0%	Active "H"	Nch open-drain output	Active "L"
R type	V _{SENSE} /14	10.0%	Active "H"	Nch open-drain output	Active "L"

3. Packages

Package Name	Dimension	Таре	Reel	Land
HTMSOP-8	FP008-A-P-SD	FP008-A-C-SD	FP008-A-R-SD	FP008-A-L-SD
HSNT-8(2030)	PP008-A-P-SD	PP008-A-C-SD	PP008-A-R-SD	PP008-A-L-SD

Pin Configurations

1. HTMSOP-8



	Bo	ottom vie	€W	
8 7 6 5			H H H H H + 1	1 2 3 4

Pin No.	Symbol	Description
1	PMEN	Supply voltage divided output enable pin
2	VDD	Voltage input pin
3	PMOUT	Supply voltage divided output pin
4	SENSE	Detection voltage input pin
5	CD*2	Connection pin for release delay time adjustment capacitor
6	VSS	GND pin
7	RO	Voltage detection output pin
8	NC ^{*3}	No connection

Table 8

Figure 3

- *1. Connect the heat sink of backside at shadowed area to the board, and set electric potential GND. However, do not use it as the function of electrode.
- *2. Connect a capacitor between the CD pin and the VSS pin. The release delay time can be adjusted according to the capacitance.

Moreover, the CD pin is available even when it is open.

***3.** The NC pin is electrically open. The NC pin can be connected to the VDD pin or the VSS pin.

2. HSNT-8(2030)

10

5 5

Top view

Bottom view

8

5

Pin No.	Symbol	Description
1	PMEN	Supply voltage divided output enable pin
2	VDD	Voltage input pin
3	PMOUT	Supply voltage divided output pin
4	SENSE	Detection voltage input pin
5	CD*2	Connection pin for release delay time adjustment capacitor
6	VSS	GND pin
7	RO	Voltage detection output pin
8	NC ^{*3}	No connection

Table 9

Figure 4

- *1. Connect the heat sink of backside at shadowed area to the board, and set electric potential GND. However, do not use it as the function of electrode.
- *2. Connect a capacitor between the CD pin and the VSS pin. The release delay time can be adjusted according to the capacitance.

Moreover, the CD pin is available even when it is open.

*3. The NC pin is electrically open. The NC pin can be connected to the VDD pin or the VSS pin. Table 10

Absolute Maximum Ratings

		(Ta =	–40°C to +105°C unless otherwise sp	pecified)
	Item	Symbol	Absolute Maximum Rating	Unit
Power supply voltage		$V_{\text{DD}} - V_{\text{SS}}$	$V_{SS} - 0.3$ to $V_{SS} + 45.0$	V
	S-19117 Series L / M / N type		V _{SS} - 30.0 to V _{SS} + 42.0	V
SENSE pin voltage	S-19117 Series P / Q / R type		Vss - 30.0 to Vss + 45.0	V
	S-19119 Series L / M / N type	VSENSE	V _{SS} - 30.0 to V _{SS} + 45.0	V
	S-19119 Series P / Q / R type		V _{SS} - 30.0 to V _{SS} + 45.0	V
CD pin input voltage		Vcd	$V_{\text{SS}} - 0.3$ to $V_{\text{DD}} + 0.3 \leq V_{\text{SS}} + 7.0$	V
PMEN pin input voltage		VPMEN	$V_{\text{SS}}-0.3$ to $V_{\text{SS}}+45.0$	V
Detector block		VRO	$V_{\text{SS}}-0.3$ to $V_{\text{SS}}+45.0$	V
Output voltage	Supply voltage divider block	VPMOUT	$V_{\text{SS}} - 0.3$ to $V_{\text{DD}} + 0.3 \leq V_{\text{SS}} + 7.0$	V
		Іоит	25	mA
Output current		Ірмоит	2	mA
Junction temperature		Tj	-40 to +150	°C
Operation ambient temperatu	Ire	Topr	-40 to +105	°C
Storage temperature		T _{stg}	-40 to +150	°C

Caution The absolute maximum ratings are rated values exceeding which the product could suffer physical damage. These values must therefore not be exceeded under any conditions.

■ Thermal Resistance Value

Table 11

Item	Symbol	Condition		Min.	Тур.	Max.	Unit
		HTMSOP-8	Board A	-	159	_	°C/W
			Board B	_	113	_	°C/W
	θ _{JA}		Board C	_	39	_	°C/W
			Board D	_	40	_	°C/W
lumetice to evolviout the uncel reciptor of *1			Board E	_	30	_	°C/W
Junction-to-ambient thermal resistance*1		HSNT-8(2030)	Board A	_	181	_	°C/W
			Board B	_	135	_	°C/W
			Board C	_	40	_	°C/W
			Board D	_	42	_	°C/W
			Board E	_	32	_	°C/W

*1. Test environment: compliance with JEDEC STANDARD JESD51-2A

Remark Refer to "**■ Power Dissipation**" and "**Test Board**" for details.

Table 12

Electrical Characteristics

1. Detector block

		(7	Га = –40°С	to +105°C	unless oth	erwise s	pecified)
Item	Symbol	Condition	Min.	Тур.	Max.	Unit	Test Circuit
Detection voltage ^{*1}	Vdet	$\begin{array}{l} V_{\text{DD}} = 13.5 \ V, \\ 4.0 \ V \leq V_{\text{DET}(S)} \leq 10.0 \ V \end{array}$	$\begin{array}{c} V_{\text{DET(S)}} \\ \times 0.985 \end{array}$	V _{DET(S)}	$V_{\text{DET(S)}} \times 1.015$	V	1
		L / P type (V _{HYS} = 0%)	_	$V_{DET} imes 0.00$	_	V	1
Hysteresis width* ²	V _{HYS}	M / Q type (V _{HYS} = 5.0%)	V _{DET} × 0.04	V _{DET} × 0.05	V _{DET} × 0.06	V	1
		N / R type (V _{HYS} = 10.0%)	V _{DET} × 0.09	V _{DET} × 0.10	V _{DET} × 0.11	V	1
Operation voltage	Vdd	_	3.0	1	36.0	V	1
Output current	Іоит	RO pin Nch driver, $V_{DD} = 3.0 \text{ V}, V_{DS}^{*3} = 0.1 \text{ V},$ $V_{SENSE} = V_{DET(S)} - 1 \text{ V}$	0.60	-	-	mA	2
Leakage current	Ileak	RO pin Nch driver, V _{DD} = 36 V, V _{RO} = 36 V, V _{SENSE} = 13.5 V	_	_	2.0	μΑ	2
Detection response time*4	tRESET	_	-	80	200	μs	3
Release delay time* ⁵	t DELAY	C _D = 3.3 nF	8.5	10.0	11.5	ms	3
SENSE pin resistance	RSENSE	V _{PMEN} = 0 V	6.8	-	200	MΩ	7
CD pin discharge ON resistance	RCDD	V_{DD} = 3.0 V, V_{CD} = 0.7 V	0.15	-	0.90	kΩ	_

*1. V_{DET}: Actual Voltage detection voltage value, V_{DET(S)}: Set voltage detection voltage value

*2. The release voltage (V_{REL}) is as follows.
 L / P type (hysteresis width "Unavailable"): V_{REL} = V_{DET}
 M / N / Q / R type (hysteresis width "Available"): V_{REL} = V_{DET} + V_{HYS}

***3.** V_{DS}: Drain-to-source voltage of the output transistor

*4. The time period from when the pulse voltage of $V_{DET(S)} + 1.0 \text{ V} \rightarrow V_{DET(S)} - 1.0 \text{ V}$ is applied to the SENSE pin after V_{SENSE} reaches the release voltage once, until V_{RO} reaches 50% of V_{DD} .

*5. $V_{\text{REL}(S)}$: Set release voltage value The time period from when the pulse voltage of $V_{\text{REL}(S)} - 1.0 \text{ V} \rightarrow V_{\text{REL}(S)} + 1.0 \text{ V}$ is applied to the SENSE pin to when V_{RO} reaches 50% of V_{DD} .

2. Supply voltage divider block

		-	(Ta	= -40°C to	+105°C ur	less other	vise sp	pecified)
Item	Symbol	Conditior	Min.	Тур.	Max.	Unit	Test Circuit	
Input voltage	Vdd	$V_{DD} \ge V_{SENSE} - 2.0 V$		3.0	-	36.0	V	-
SENSE pin voltage	VSENSE	_		5.0	-	36.0	V	_
			V _{SENSE} /6 output product	$\begin{array}{c} V_{\text{PMOUT(S)}} \\ \times \ 0.980 \end{array}$	Vsense/6	Vpmout(s) × 1.020	V	4
Output voltage of		$\begin{array}{l} 3.0 \ V \leq V_{DD} \leq 18.0 \ V, \\ 5.0 \ V \leq V_{SENSE} \leq 18.0 \ V, \\ -10 \ \mu A \leq I_{PMOUT} \leq 10 \ \mu A \end{array}$	V _{SENSE} /8 output product	$\begin{array}{c} V_{\text{PMOUT(S)}} \\ \times \ 0.975 \end{array}$	Vsense/8	Vpmout(s) × 1.025	V	4
supply voltage divider block*1	Vpmout	-10 μΑ ≤ ΙΡΜΟΟΤ ≤ 10 μΑ	V _{SENSE} /12 output product	$\begin{array}{c} V_{\text{PMOUT(S)}} \\ \times \ 0.970 \end{array}$	V _{SENSE} /12	Vpmout(s) × 1.030	V	4
		3.0 V \leq V _{DD} \leq 18.0 V, 5.0 V \leq V _{SENSE} \leq 18.0 V, $-3 \mu A \leq$ IPMOUT \leq 3 μA	V _{SENSE} /14 output product	$\begin{array}{c} V_{\text{PMOUT(S)}} \\ \times \ 0.966 \end{array}$	Vsense/14	Vpmout(s) × 1.034	V	4
Load current	IPMOUT	V _{SENSE} /6 output product, V _{SENSE} /8 output product, V _{SENSE} /12 output product		-10	_	10	μΑ	4
		VSENSE/14 output product	-3	-	3	μA	4	
Output impedance	R _{PS}	$\begin{array}{l} 3.0 \ V \leq V_{DD} \leq 18.0 \ V, \\ 5.0 \ V \leq V_{SENSE} \leq 18.0 \ V \end{array}$		-	-	1000	Ω	4
Set-up time*²	t _{PU}	V _{DD} = 18.0 V, V _{SENSE} = 18.0 V, C _{PM} = 0.22 μF, no load, t _r = 1.0 μs		_	15	30	ms	5
PMEN pin input voltage "H"	Vpsh	V _{DD} = 18.0 V, determined by V _{PMOUT} out	out level	1.3	-	_	V	6
PMEN pin input voltage "L"	V _{PSL}	V _{DD} = 18.0 V, determined by V _{PMOUT} output level		-	-	0.3	V	6
PMEN pin input current "H"	IPSH	$V_{DD} = 18.0 \text{ V}, \text{V}_{PMEN} = V_{DD}$		0.00	-	0.50	μA	6
PMEN pin input current "L"	IPSL	V _{DD} = 18.0 V, V _{PMEN} = 0 V		-0.1	-	0.1	μA	6
SENSE pin resistance during operation of supply voltage divider block	Rpmsense	V _{PMEN} = V _{DD}		5.8	_	140	MΩ	7
Discharge shunt resistance during power-off	R _{PLOW}	V _{DD} = 13.5 V, V _{PMEN} = 0 V	V _{DD} = 13.5 V, V _{PMEN} = 0 V, V _{PMOUT} = 0.1 V			-	kΩ	8

Table 13

*1. V_{PMOUT}: Actual output voltage value of supply voltage divider block, V_{PMOUT(S)}: Set output voltage value of supply voltage divider block

*2. Set-up time shows the time period from when the input voltage reaches 50% until the output voltage of supply voltage divider block rises to 99%, when the PMEN pin is set to ON (t_r = 1.0 μs).

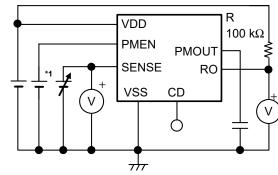
3. Overall

		(Ta = –	40°C to +1	105°C unle	ess otherv	/ise sp	ecified)
Item	Symbol	Condition	Min.	Тур.	Max.	Unit	Test Circuit
Current consumption	I _{SS1}	During supply voltage divided output stops, V _{DD} = 13.5 V, V _{SENSE} = 13.5 V, V _{PMEN} = 0 V	_	0.75	3.0	μA	7
	I _{SSP1}	During supply voltage divided output operates, V_{DD} = 13.5 V, V_{SENSE} = 13.5 V, V_{PMEN} = V_{DD} , no load	_	1.15	5.4	μΑ	7

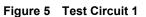
Table 14

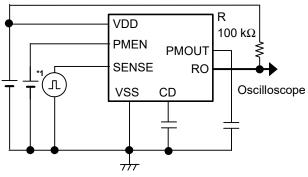
AUTOMOTIVE, 105°C OPERATION, 36 V, SUPPLY VOLTAGE DIVIDED OUTPUT, VOLTAGE DETECTOR WITH SENSE PIN REVERSE CONNECTION PROTECTION S-19117/19119xxxH Series Rev.1.1_00

Test Circuits



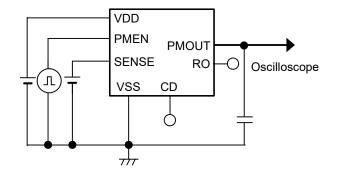
*1. Set to ON





*1. Set to ON







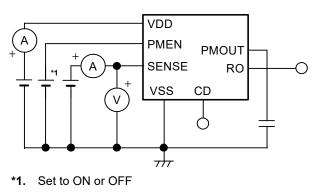


Figure 11 Test Circuit 7

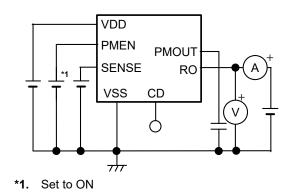


Figure 6 Test Circuit 2

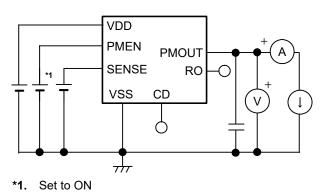
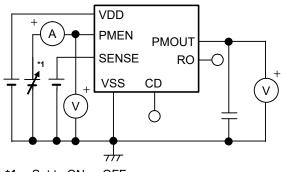


Figure 8 Test Circuit 4



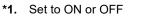
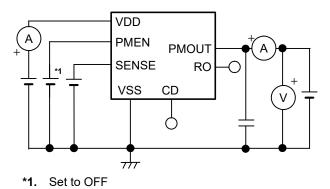


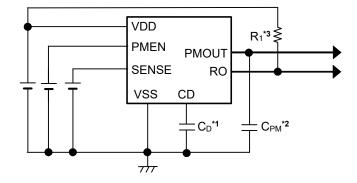
Figure 10 Test Circuit 6





ABLIC Inc.

Standard Circuit



- *1. C_D is a release delay time adjustment capacitor. The C_D should be connected directly to the CD pin and the VSS pin.
- *2. C_{PM} is a capacitor for stabilizing the output. The C_{PM} should be connected directly to the PMOUT pin and the VSS pin.
- ***3.** R₁ are the external pull-up resistors for the reset output pin.

Figure 13

Caution The above connection diagram and constants will not guarantee successful operation. Perform thorough evaluation including the temperature characteristics with an actual application to set the constants.

■ Condition of Application

Release delay time adjustment capacitor (C_D): A ceramic capacitor with capacitance of 1.0 nF or more is recommended. Supply voltage divider block output capacitor (C_{PM}): A ceramic capacitor with capacitance of 0.1 μ F to 0.22 μ F is recommended.

Caution 1. The CD pin is available even when it is open.

Refer to "1. Power on sequence" in "■ Usage Precautions" when using it open.

2. Generally, in a supply voltage divider, an oscillation may occur depending on the selection of the external parts. Perform thorough evaluation including the temperature characteristics with an actual application using the above capacitors to confirm no oscillation occurs.

■ Selection of Release Delay Time Adjustment Capacitor (C_D)

In this IC, the release delay time adjustment capacitor (C_D) is necessary between the CD pin and the VSS pin to adjust the release delay time (t_{DELAY}) of the detector. Refer to "1.4 Delay circuit" in "**■** Operation" for details.

Caution Perform thorough evaluation including the temperature characteristics with an actual application to select C_D.

■ Selection of Supply Voltage Divider Block Output Capacitor (C_{PM})

This IC requires C_{PM} between the PMOUT pin and the VSS pin for phase compensation. The operation is stabilized by a ceramic capacitor with capacitance of 0.1 μ F to 0.22 μ F. When using an OS capacitor, a

The operation is stabilized by a ceramic capacitor with capacitance of 0.1 μ F to 0.22 μ F. When using an OS capacitor, a tantalum capacitor or an aluminum electrolytic capacitor, the capacitance also must be 0.1 μ F to 0.22 μ F. However, an oscillation may occur depending on the equivalent series resistance (ESR).

Caution Perform thorough evaluation including the temperature characteristics with an actual application to select C_{PM}.

Explanation of Terms

1. Detector block

1.1 Detection voltage (VDET)

The detection voltage is a SENSE pin voltage at which the output voltage in **Figure 16** turns to "L". The detection voltage varies slightly among products of the same specification. The variation of detection voltage between the specified minimum and the maximum is called the detection voltage range (Refer to "**Figure 14 Detection Voltage**").

Example: In V_{DET} = 4.0 V product, the detection voltage is at any point in the range of 3.940 V \leq V_{DET} \leq 4.060 V. This means that some V_{DET} = 4.0 V product has V_{DET} = 3.940 V and some has V_{DET} = 4.060 V.

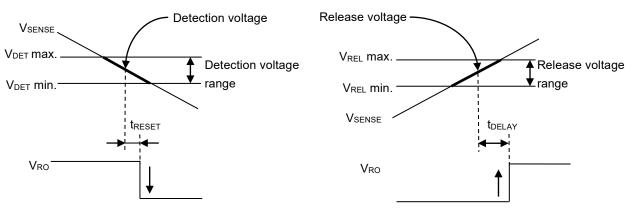
1.2 Release voltage (VREL)

The release voltage is a SENSE pin voltage at which the output voltage in **Figure 16** turns to "H". The release voltage varies slightly among products of the same specification. The variation of release voltage between the specified minimum and the maximum is called the release voltage range (Refer to "**Figure 15 Release Voltage**"). The release voltage becomes the value differs from the detection voltage within the range shown below.

- M / Q type: 4% to 6% (5% typ.)
- N / R type: 9% to 11% (10% typ.)
- Example: For N / R type, V_{DET} = 4.0 V product, the release voltage is at any point in the range of 4.294 V \leq V_{REL} \leq 4.507 V despite V_{REL} = 4.400 V typ.

This means that some N / R type, V_{DET} = 4.0 V product has V_{REL} = 4.294 V and some has V_{REL} = 4.507 V.

AUTOMOTIVE, 105°C OPERATION, 36 V, SUPPLY VOLTAGE DIVIDED OUTPUT, VOLTAGE DETECTOR WITH SENSE PIN REVERSE CONNECTION PROTECTION Rev.1.1_00 S-19117/19119xxxH Series







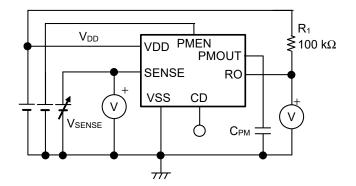


Figure 16 Test Circuit of Detection Voltage and Release Voltage

1.3 Hysteresis width (V_{HYS})

The hysteresis width is the voltage difference between the detection voltage (V_{DET}) and the release voltage (V_{REL}). Voltage difference between V_{REL} and V_{DET} is the hysteresis width (V_{HYS}^{*1}) of the RO pin. Setting the hysteresis width between V_{DET} and V_{REL} , prevents malfunction caused by noise on the input voltage.

*1. Refer to "1.2 S-19117/19119 Series M / N / Q / R type" in " Operation" for details.

1.4 Feed-through current

The feed-through current is a current that flows instantaneously to the VDD pin at the time of detection and release of a voltage detector.

2. Supply voltage divider block

2.1 Supply voltage divided output

The supply voltage divided output is a function that divides the SENSE pin voltage (V_{SENSE}) into V_{SENSE}/6, V_{SENSE}/8, V_{SENSE}/12 or V_{SENSE}/14 and outputs the voltage.

For example, a microcontroller can monitor a battery voltage by inputting the output voltage of supply voltage divider block (V_{PMOUT}) to the microcontroller A/D converter.

2. 2 Output voltage of supply voltage divider block (VPMOUT)

This is the voltage of the divided V_{SENSE} . The following voltages are the outputs.

- S-19117 Series L / M / N type: VSENSE/6
- S-19117 Series P / Q / R type: VSENSE/8
- S-19119 Series L / M / N type: VSENSE/12
- S-19119 Series P / Q / R type: VSENSE/14

This voltage is the output in accuracy range of between $\pm 2.0\%$ and $\pm 3.4\%^{*1}$ when the power supply voltage, V_{SENSE}, temperature and load current satisfy a certain condition^{*1}.

- ***1.** Differs depending on the product type.
- Example: For S-19117 Series L / M / N type, V_{SENSE} = 15.0 V, the output voltage of supply voltage divider block is at any point in the range of 2.450 V ≤ V_{PMOUT} ≤ 2.550 V. This means that some S-19117 Series L / M / N type has V_{PMOUT} = 2.450 V and some has V_{PMOUT} = 2.550 V.

Caution If the certain condition is not satisfied, the output voltage may exceed the accuracy range. Refer to Table 13 of "■ Electrical Characteristics" for details.

2. 3 Output impedance (R_{PS})

This is the supply voltage divider block impedance. It shows how much output offset voltage changes when the load current changes.

For example, the output impedance can be used in sampling rate calculation as signal source impedance when V_{PMOUT} from the PMOUT pin is input to the A/D converter as a microcontroller input signal.

2.4 Set-up time (t_{PU})

This is the time from when the supply voltage divided output is operated until VPMOUT stabilizes.

2. 5 Discharge shunt resistance during power-off (RPLOW)

This is the ON resistance of the N-channel transistor built into the supply voltage divider block. When the supply voltage divided output is stopped, V_{PMOUT} is set to the V_{SS} level by the built-in N-channel transistor.

Operation

1. Detector block

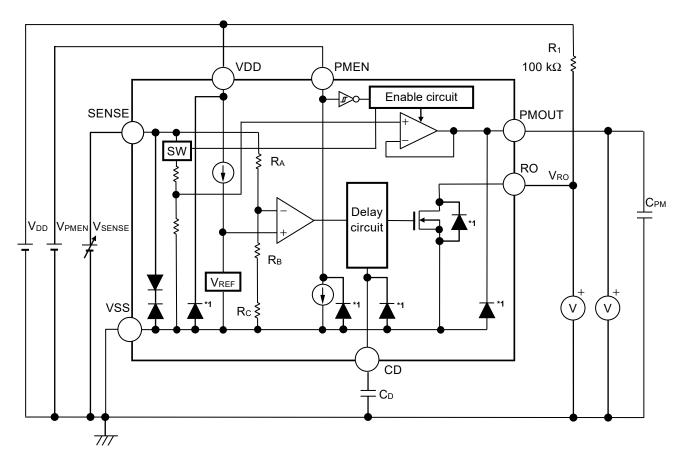
Figure 17 and **Figure 19** show that the RO pin being pulled up by resistors (R_1) is an example of basic detector block operation.

1.1 S-19117/19119 Series L / P type

(1) When the power supply voltage (V_{DD}) is the minimum operation voltage or higher, and the SENSE pin voltage (V_{SENSE}) is the release voltage (V_{REL}) or higher, the Nch transistor is turned off to output V_{DD} ("H") when the output is pulled up.

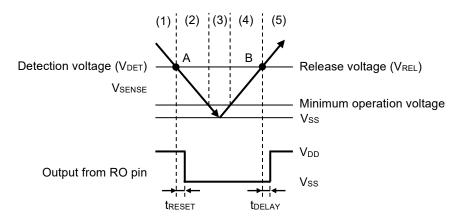
At this time, the input voltage to the comparator is $\frac{(R_B + R_C) \bullet V_{SENSE}}{R_A + R_B + R_C}$

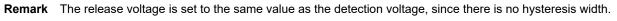
- (2) When V_{SENSE} decreases to the detection voltage (V_{DET}) or lower (point A in **Figure 18**), the Nch transistor is turned on. And then V_{SS} ("L") is output from the RO pin after the elapse of the detection response time (t_{RESET}).
- (3) Even if V_{SENSE} further decreases to the IC's minimum operation voltage or lower, the output from the RO pin is stable when V_{DD} is minimum operation voltage or higher.
- (4) Even if V_{SENSE} increases, V_{SS} is output when V_{SENSE} is lower than V_{REL} .
- (5) When V_{SENSE} increases to V_{REL} or higher (point B in **Figure 18**), the Nch transistor is turned off. And then V_{DD} is output from the RO pin after the elapse of the release delay time (t_{DELAY}) when the output is pulled up.

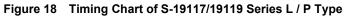


*1. Parasitic diode

Figure 17 Operation of S-19117/19119 Series L / P type







1. 2 S-19117/19119 Series M / N / Q / R type

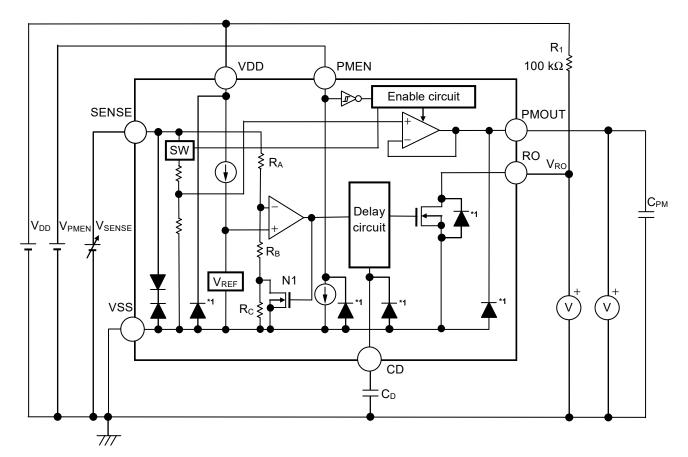
(1) When the power supply voltage (V_{DD}) is the minimum operation voltage or higher, and the SENSE pin voltage (V_{SENSE}) is the release voltage (V_{REL}) or higher, the Nch transistor is turned off to output V_{DD} ("H") when the output is pulled up.

Since the Nch transistor (N1) is turned off, the input voltage to the comparator is $\frac{(R_B + R_C) \bullet V_{SENSE}}{R_A + R_B + R_C}$

(2) Even if V_{SENSE} decreases to V_{REL} or lower, V_{DD} is output when V_{SENSE} is higher than the detection voltage (V_{DET}). When V_{SENSE} decreases to V_{DET} or lower (point A in **Figure 20**), the Nch transistor is turned on. And then V_{SS} ("L") is output from the RO pin after the elapse of the detection response time (t_{RESET}).

At this time, N1 is turned on, and the input voltage to the comparator is $\frac{R_B \bullet V_{SENSE}}{R_A + R_B}$

- (3) Even if V_{SENSE} further decreases to the IC's minimum operation voltage or lower, the output from the RO pin is stable when V_{DD} is minimum operation voltage or higher.
- (4) Even if VSENSE exceeds VDET, VSS is output when VSENSE is lower than VREL.
- (5) When V_{SENSE} increases to V_{REL} or higher (point B in **Figure 20**), the Nch transistor is turned off. And then V_{DD} is output from the RO pin after the elapse of the release delay time (t_{DELAY}) when the output is pulled up.



*1. Parasitic diode

Figure 19 Operation of S-19117/19119 Series M / N / Q / R type

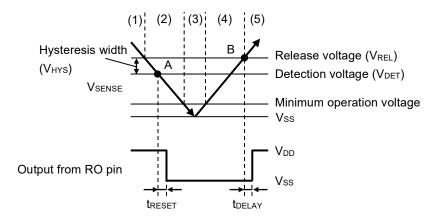


Figure 20 Timing Chart of S-19117/19119 Series M / N / Q / R Type

1.3 SENSE pin

The SENSE pin is the input pin for the detection voltage. The power supply VDD pin and SENSE pin, for voltage detection, are divided. Therefore, as long as a voltage is supplied to the VDD pin, the reset signal will be held even if the input voltage to the SENSE pin drops below the minimum operation voltage. Also, the SENSE pin of this IC has a built-in reverse connection protection circuit. Even when the SENSE pin voltage is less than the VSS pin voltage, the voltage flowing from the VSS pin to the SENSE pin is reduced to 0.05 mA typ.

1. 3. 1 Error when detection voltage is set externally

The detection voltage can be set externally by connecting a node that was resistance-divided by the resistor (R_A) and the resistor (R_B) to the SENSE pin as shown in **Figure 21**.

For conventional products without the SENSE pin, external resistor cannot be too large since the resistance-divided node must be connected to the VDD pin. This is because a feed-through current will flow through the VDD pin when it goes from detection to release, and if external resistor is large, problems such as oscillation or larger error in the hysteresis width may occur.

In this IC, R_A and R_B in **Figure 21** are easily made larger since the resistance-divided node can be connected to the SENSE pin through which no feed-through current flows. However, be careful of error in the current flowing through the internal resistance (R_{SENSE}) that will occur.

Although R_{SENSE}^{*1} in this IC is large to make the error small, R_A and R_B should be selected such that the error is within the allowable limits.

Please note that the supply voltage divided output is a function to divide and output the SENSE pin voltage so when the detection voltage is set externally, care is required as the supply voltage divider block output voltage will change.

*1. During supply voltage divided output stops: 6.8 M Ω min. During supply voltage divided output operates: 5.8 M Ω min.

1. 3. 2 Selection of R_A and R_B

In **Figure 21**, the relation between the external setting detection voltage (V_{DX}) and the actual detection voltage (V_{DET}) is ideally calculated by the equation below.

$$V_{DX} = V_{DET} \times \left(1 + \frac{R_A}{R_B}\right) \dots (1)$$

However, in reality there is an error in the current flowing through R_{SENSE} . When considering this error, the relation between V_{DX} and V_{DET} is calculated as follows.

By using equations (1) and (2), the error is calculated as $V_{\text{DET}} \times \frac{R_{\text{A}}}{R_{\text{SENSE}}}$

The error rate is calculated as follows by dividing the error by the right-hand side of equation (1).

$$\frac{R_A \times R_B}{R_{SENSE} \times (R_A + R_B)} \times 100 \ [\%] = \frac{R_A \parallel R_B}{R_{SENSE}} \times 100 \ [\%] \quad \cdots (3)$$

As seen in equation (3), the smaller the resistance values of R_A and R_B compared to R_{SENSE}, the smaller the error rate becomes.

Also, the relation between the external setting hysteresis width (V_{HX}) and the hysteresis width (V_{HYS}) is calculated by equation below. Error due to R_{SENSE} also occurs to the relation in a similar way to the detection voltage.

$$V_{HX} = V_{HYS} \times \left(1 + \frac{R_A}{R_B}\right) \cdots (4)$$

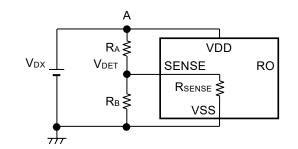


Figure 21 Detection Voltage External Setting Circuit

Caution If R_A and R_B are large, the SENSE pin input impedance becomes higher and may cause a malfunction due to noise. In this case, connect a capacitor between the SENSE pin and the VSS pin.

1.4 Delay circuit

The delay circuit has a function that adjusts the release delay time (t_{DELAY}) from when the SENSE pin voltage (V_{SENSE}) reaches the release voltage ($V_{REL} = V_{DET} + V_{HYS}$) or higher to when the output from RO pin inverts. t_{DELAY} is determined by the delay coefficient, the release delay time adjustment capacitor (C_D) and the release delay time when the CD pin is open (t_{DELAY0}). They are calculated by the equations below.

 t_{DELAY} [ms] = Delay coefficient × C_D [nF] + t_{DELAY0} [ms]

Operation		Delay Coefficient					
Temperature	Min.	Тур.	Max.				
Ta = +105°C	2.71	3.05	3.35				
Ta = +25°C	2.92	3.06	3.14				
Ta = -40°C	2.65	3.09	3.41				

Table 15

Table	16	

Operation	Release Delay Time when CD Pin is Open (t _{DELAY0})					
Temperature	Min.	Тур.	Max.			
Ta = +105°C	0.05	0.10	0.17			
Ta = +25°C	0.06	0.11	0.19			
Ta = -40°C	0.06	0.13	0.25			

- Caution 1. Mounted board layout should be made in such a way that no current flows into or flows from the CD pin since the impedance of the CD pin is high, otherwise correct delay time cannot be provided.
 - 2. There is no limit for the capacitance of C_D as long as the leakage current of the capacitor can be ignored against the built-in constant current value (approximately 160 nA). The leakage current may cause error in delay time. When the leakage current is larger than the built-in constant current, no detect or release takes place.
 - The above equations will not guarantee successful operation. Determine the capacitance of C_D through thorough evaluation including temperature characteristics in the actual usage conditions.

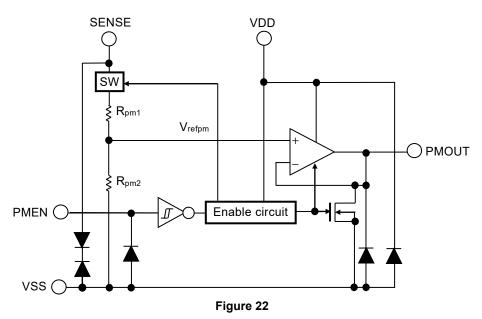
2. Supply voltage divider block

2.1 Basic operation

Figure 22 shows the block diagram of the supply voltage divider block to describe basic operation.

Reference voltage (V_{refpm}) is generated by dividing the SENSE pin voltage (V_{SENSE}) using the dividing resistance (R_{pm1} and R_{pm2}). Since the buffer amplifier constitutes a voltage follower, it can perform the feedback control so that the output voltage of supply voltage divider block (V_{PMOUT}) and V_{refpm} are the same. Low output impedance is realized by the buffer amplifier, while outputting V_{PMOUT} according to V_{SENSE} .

When "L" is input to the PMEN pin, the current which flows to R_{pm1} and R_{pm2} and the current which flows to the buffer amplifier can be stopped. The buffer amplifier output is pulled down to V_{SS} by the built-in N-channel transistor, and V_{PMOUT} is set to the V_{SS} level.



2.2 PMEN pin

Input to the PMEN pin controls the internal circuit in the supply voltage divided output, and it starts or stops the supply voltage divided output.

When the PMEN pin is set to "L" level, the internal circuit stops operating, reducing current consumption significantly. In addition, the PMEN pin has absolutely no effect on the operation of the detector block.

Note that the current consumption increases when a voltage of 0.8 V to V_{DD} min. – 0.3 V is applied to the PMEN pin. The PMEN pin is configured as shown in **Figure 23**.

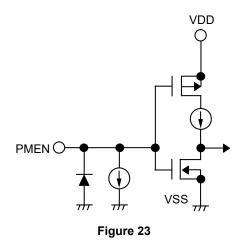
Since the PMEN pin is internally pulled down to the VSS pin in the floating status, the PMOUT pin is set to the Vss level. When the PMEN pin is set to "H" level, PMEN pin input current "H" (IPSH) in **Table 13** of "■ **Electrical Characteristics**" flows through the PMEN pin and care is required.

Table 1	7
---------	---

Product Type	PMEN Pin	Internal Circuit	PMOUT Pin Output	Current Consumption
L/M/N/P/Q/R	"H": ON	Operate	Constant value ^{*1}	ISSP1
L/M/N/P/Q/R	"L": OFF	Stop	Pulled down to Vss*2	Iss1

*1. The constant value is output due to the operation based on the set output voltage value of supply voltage divider block.

^{*2.} The buffer amplifier output is pulled down to V_{SS} by the built-in N-channel transistor, and PMOUT pin output is set to the V_{SS} level due to resistance (R_{LOW} = 2.8 kΩ typ.) of the discharge shunt circuit and a load.



2. 3 PMEN pin voltage and output voltage of supply voltage divider block (VPMOUT)

Figure 24 shows the timing chart of the supply voltage divided output.

When "H" is input to the PMEN pin, the supply voltage divided output operates. When the set-up time (t_{PU}) = 50 ms max.^{*1} elapses, V_{PMOUT} stabilizes, the SENSE pin voltage (V_{SENSE}) is divided at the set ratio, and the voltage is output to the PMOUT pin.

When "L" is input to the PMEN pin, the supply voltage divided output is stopped. V_{PMOUT} is set to the V_{SS} level by the built-in N-channel transistor.

By repeatedly inputting "H" and "L" to the PMEN pin, it is possible to lower current consumption when the supply voltage divided output is not needed.

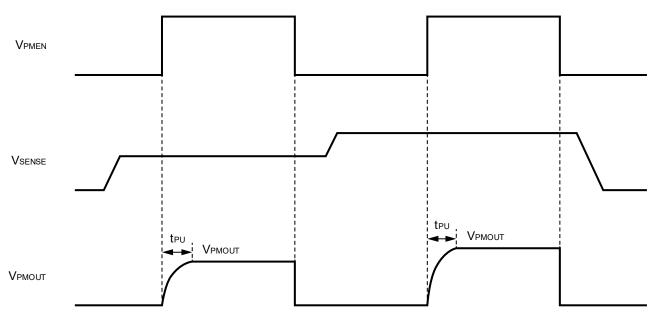




Figure 24

Remark $V_{PMEN} = V_{DD} \leftrightarrow V_{SS}$

Usage Precautions

1. Power on sequence

1.1 Power on when release delay time adjustment capacitor (C_D) \ge 1 nF

When connecting a 1 nF or larger capacitor to the CD pin, there is no specific order for turning on the SENSE and VDD pins.

1.2 Power on when release delay time adjustment capacitor $(C_D) < 1$ nF or CD pin is open

When connecting a capacitor of less than 1 nF to the CD pin, turn on the VDD pin before the SENSE pin as shown in **Figure 25**.

When $V_{SENSE} \ge V_{REL}$ applies, output voltage (V_{RO}) becomes "H", and the detector enters release status.

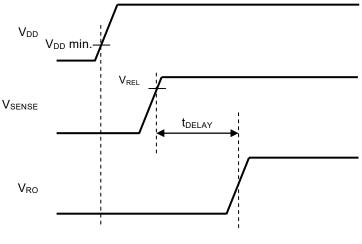


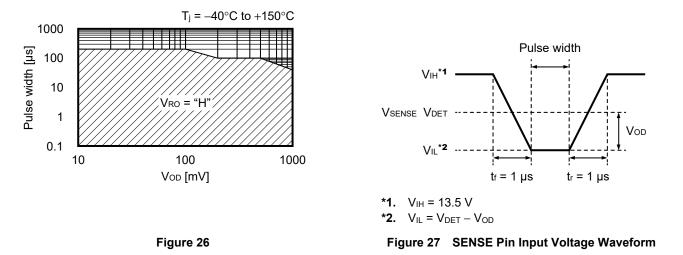
Figure 25

Caution When connecting a capacitor of less than 1 nF to the CD pin and the SENSE pin is turned on before the VDD pin, a release may mistakenly occur even if V_{SENSE} is less than V_{REL}.

2. SENSE pin voltage glitch (Typical data)

2.1 Detection operation

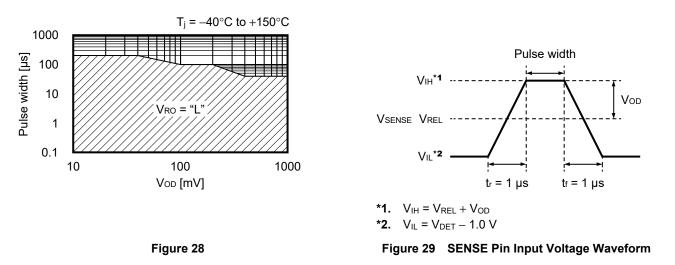
Figure 26 shows the relation between pulse width and pulse voltage difference (V_{OD}) where the release status can be maintained when a pulse equal to or lower than the detection voltage (V_{DET}) is input to the SENSE pin during release status.



Caution Figure 26 shows the pulse condition which can maintain the release status. If the pulse whose pulse width and V_{OD} are larger than this condition is input to the SENSE pin, the RO pin may change to a detection status.

2.2 Release operation

Figure 28 shows the relation between pulse width and pulse voltage difference (V_{OD}) where the detection status can be maintained when a pulse equal to or higher than the release voltage (V_{REL}) is input to the SENSE pin during detection status.



Caution Figure 28 shows the pulse condition which can maintain the detection status. If the pulse whose pulse width and V_{OD} are larger than this condition is input to the SENSE pin, the RO pin may change to a release status.

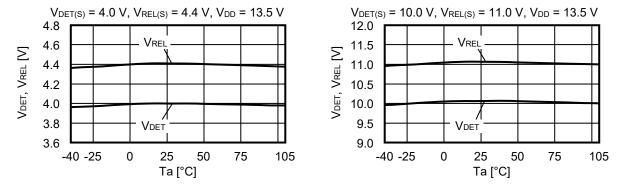
Precautions

- Do not apply an electrostatic discharge to this IC that exceeds the performance ratings of the built-in electrostatic protection circuit.
- Because the SENSE pin has a high impedance, malfunctions may occur due to noise. Be careful of wiring adjoining SENSE pin wiring in actual applications.
- In the supply voltage divided output, the values of an overshoot and an undershoot in the output voltage vary depending on the variation factors of input voltage start-up, input voltage fluctuation and load fluctuation etc., or the capacitance of C_{PM} and the value of the equivalent series resistance (ESR), which may cause a problem to the stable operation. Perform thorough evaluation including the temperature characteristics with an actual application to select C_{PM}.
- When designing for mass production using an application circuit described herein, the product deviation and temperature characteristics should be taken into consideration. ABLIC Inc. shall not bear any responsibility for patent infringements related to products using the circuits described herein.
- ABLIC Inc. claims no responsibility for any disputes arising out of or in connection with any infringement by products including this IC of patents owned by a third party.

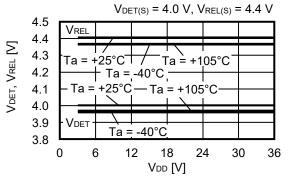
Characteristics (Typical Data)

1. Detector block

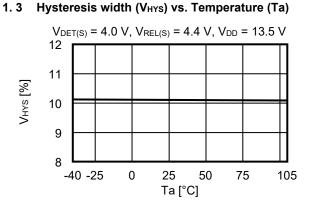
1.1 Detection voltage (V_{DET}), Release voltage (V_{REL}) vs. Temperature (Ta)

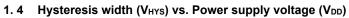


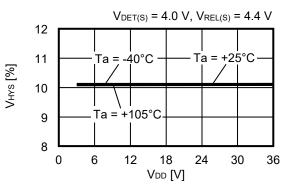
1.2 Detection voltage (VDET), Release voltage (VREL) vs. Power supply voltage (VDD)

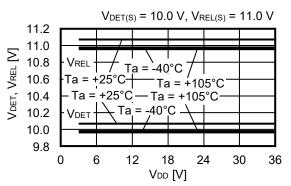


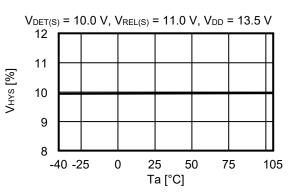


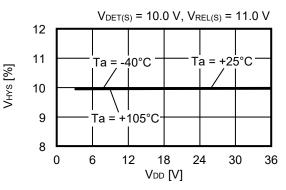


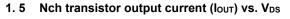


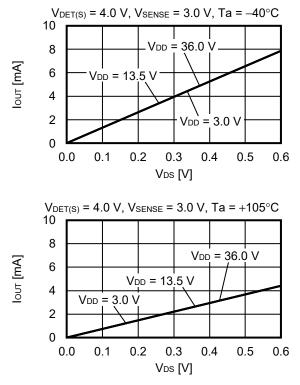


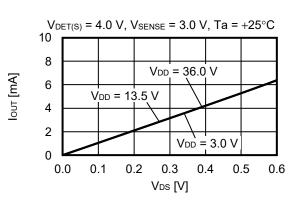






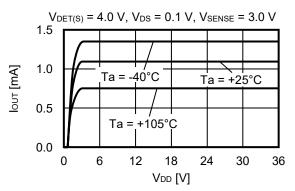


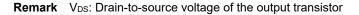




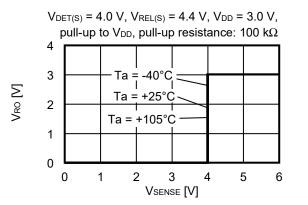
Remark V_{DS}: Drain-to-source voltage of the output transistor

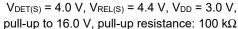
1.6 Nch transistor output current (IOUT) vs. Power supply voltage (VDD)

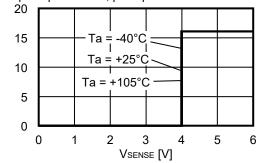




1.7 Output voltage (VRO) vs. SENSE pin voltage (VSENSE)



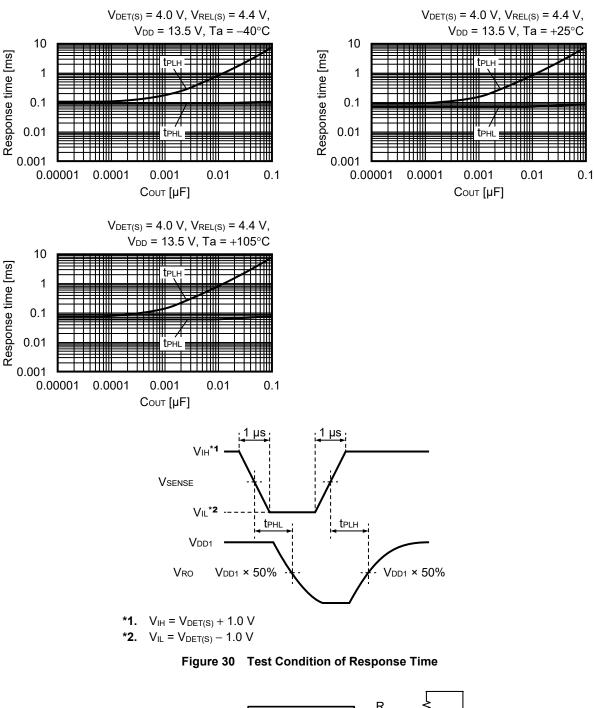


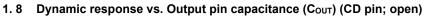


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AUTOMOTIVE, 105°C OPERATION, 36 V, SUPPLY VOLTAGE DIVIDED OUTPUT, VOLTAGE DETECTOR WITH SENSE PIN REVERSE CONNECTION PROTECTION S-19117/19119xxxH Series Rev.1.1_00





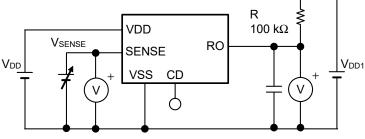
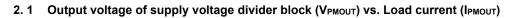
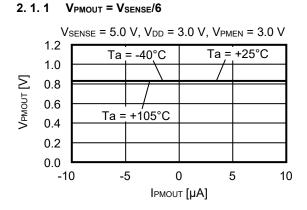


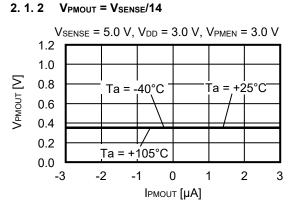
Figure 31 Test Circuit of Response Time

Caution The above connection diagram and constants will not guarantee successful operation. Perform thorough evaluation including the temperature characteristics with an actual application to set the constants.

2. Supply voltage divider block

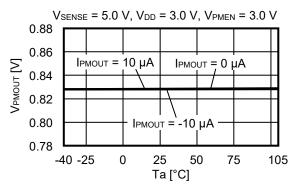




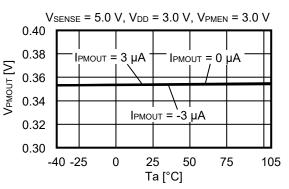


2. 2 Output voltage of supply voltage divider block (VPMOUT) vs. Temperature (Ta)



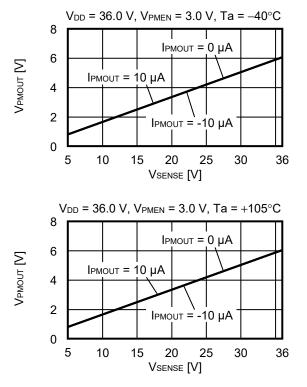


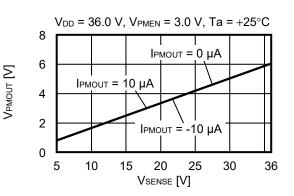
2. 2. 2 VPMOUT = VSENSE/14



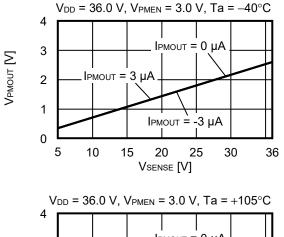
2.3 Output voltage of supply voltage divider block (VPMOUT) vs. SENSE pin voltage (VSENSE)

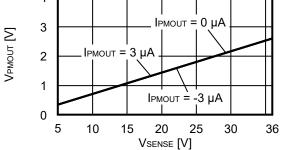
2. 3. 1 VPMOUT = VSENSE/6

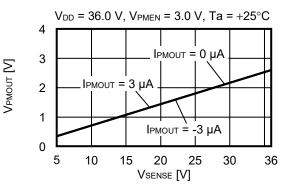




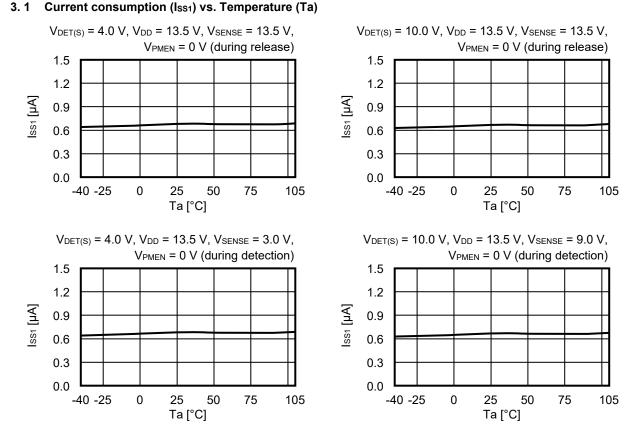
2. 3. 2 VPMOUT = VSENSE/14



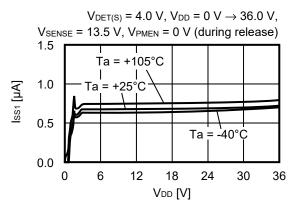


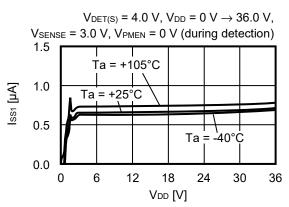


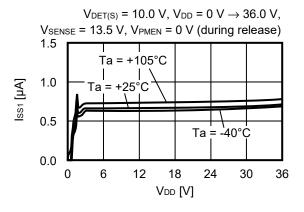
3. Overall

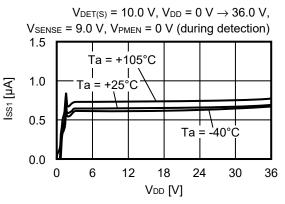


3. 2 Current consumption (Iss1) vs. Power supply voltage (VDD) (No load)

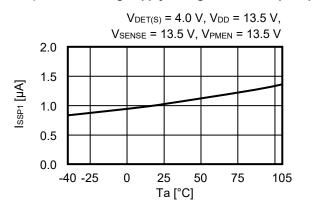


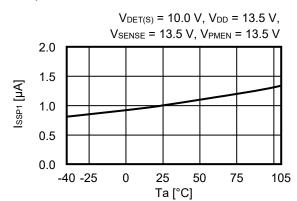




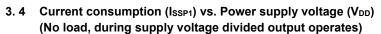


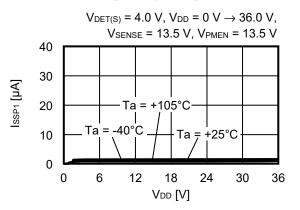
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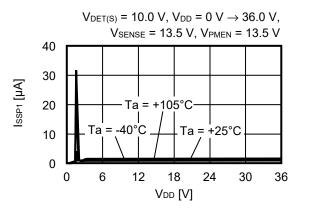


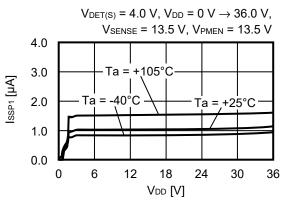


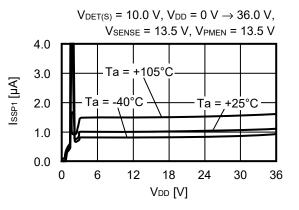
3. 3 Current consumption (I_{SSP1}) vs. Temperature (Ta) (No load, during supply voltage divided output operates)











Reference Data

- 1. Detection response time (t_{RESET}) vs. Temperature (Ta)
- 2. Detection response time (treset) vs. Power supply voltage (VDD)

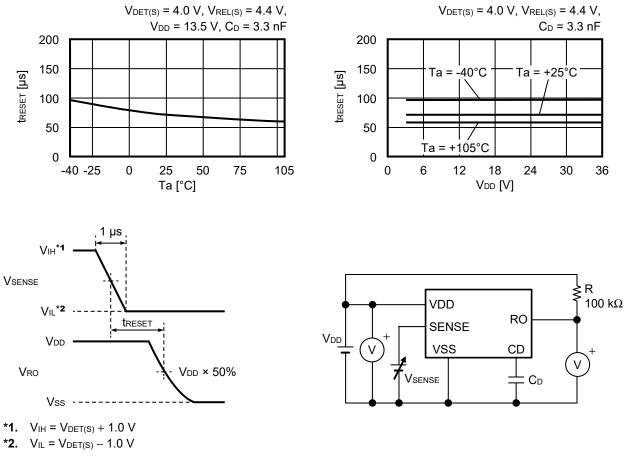


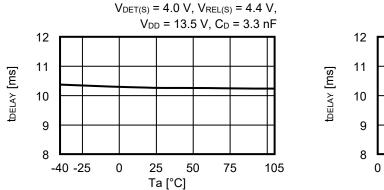
Figure 32 Test Condition of Detection Response Time Figure 33 Test Circuit of Detection Response Time

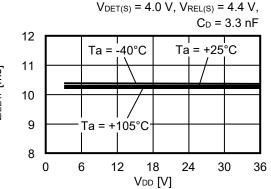
Caution The above connection diagram and constants will not guarantee successful operation. Perform thorough evaluation including the temperature characteristics with an actual application to set the constants.

AUTOMOTIVE, 105°C OPERATION, 36 V, SUPPLY VOLTAGE DIVIDED OUTPUT, VOLTAGE DETECTOR WITH SENSE PIN REVERSE CONNECTION PROTECTION S-19117/19119xxxH Series Rev.1.1_00

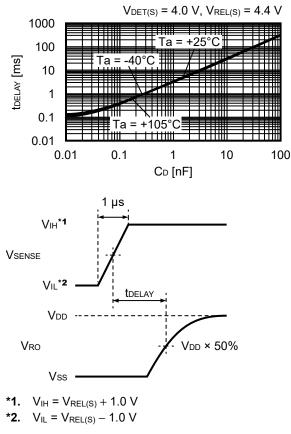
3. Release delay time (t_{DELAY}) vs. Temperature (Ta)

4. Release delay time (t_{DELAY}) vs. Power supply voltage (V_{DD})









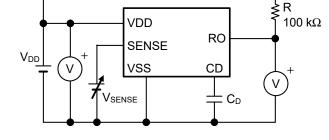
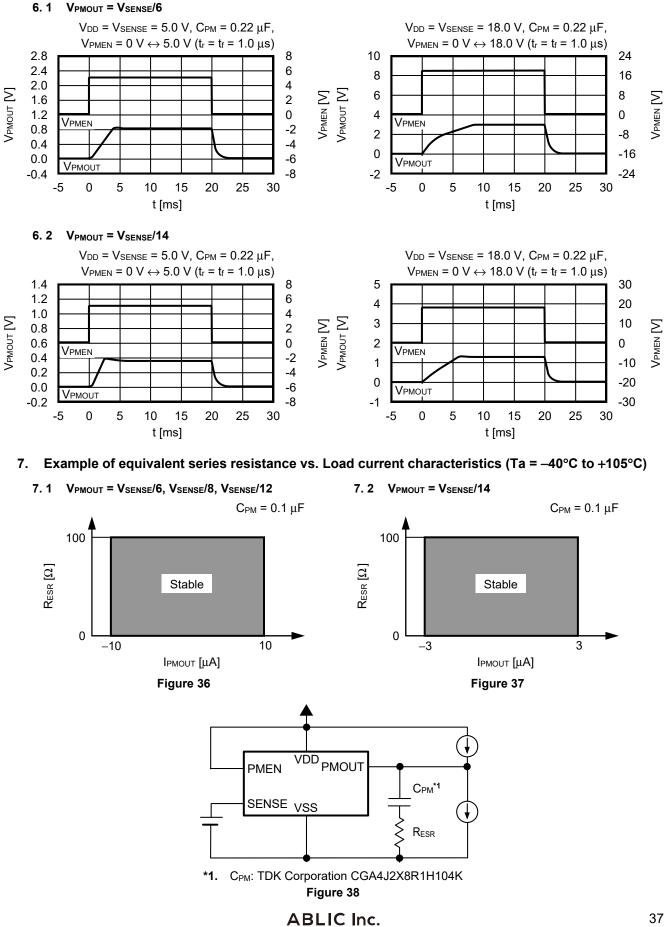


Figure 34 Test Condition of Release Delay Time



Caution The above connection diagram and constants will not guarantee successful operation. Perform thorough evaluation including the temperature characteristics with an actual application to set the constants.

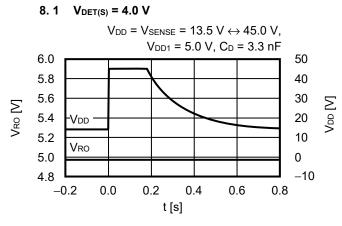
AUTOMOTIVE, 105°C OPERATION, 36 V, SUPPLY VOLTAGE DIVIDED OUTPUT, VOLTAGE DETECTOR WITH SENSE PIN REVERSE CONNECTION PROTECTION Rev.1.1 00 S-19117/19119xxxH Series



6. Transient response characteristics of PMEN pin (Ta = +25°C)

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8. Load dump characteristics (Ta = +25°C)



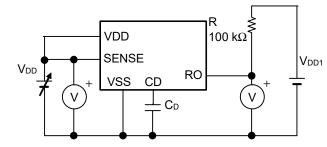
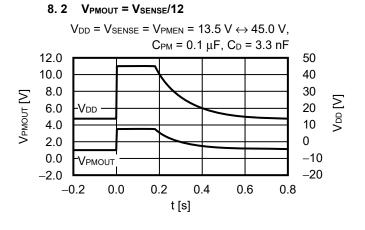


Figure 39



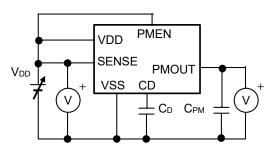
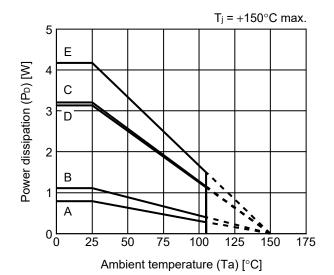


Figure 40

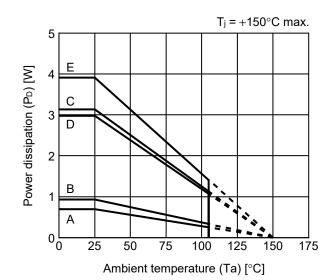
Power Dissipation

HTMSOP-8

HSNT-8(2030)



Board	Power Dissipation (P _D)
Α	0.79 W
В	1.11 W
С	3.21 W
D	3.13 W
E	4.17 W

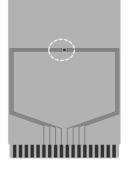


Board	Power Dissipation (P _D)
Α	0.69 W
В	0.93 W
С	3.13 W
D	2.98 W
E	3.91 W

HTMSOP-8 Test Board

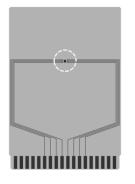
) IC Mount Area

(1) Board A



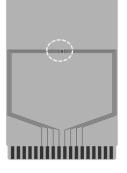
	Specification
	114.3 x 76.2 x t1.6
	FR-4
ayer	2
1	Land pattern and wiring for testing: t0.070
2	-
3	-
4	74.2 x 74.2 x t0.070
	-
	1 2 3

(2) Board B



Item		Specification
Size [mm]		114.3 x 76.2 x t1.6
Material		FR-4
Number of copper foil la	ayer	4
Copper foil layer [mm]	1	Land pattern and wiring for testing: t0.070
	2	74.2 x 74.2 x t0.035
	3	74.2 x 74.2 x t0.035
	4	74.2 x 74.2 x t0.070
Thermal via		-

(3) Board C



Item		Specification
Size [mm]		114.3 x 76.2 x t1.6
Material		FR-4
Number of copper foil la	ayer	4
	1	Land pattern and wiring for testing: t0.070
Copper foil layer [mm]	2	74.2 x 74.2 x t0.035
	3	74.2 x 74.2 x t0.035
	4	74.2 x 74.2 x t0.070
Thermal via		Number: 4 Diameter: 0.3 mm

≣∎≣

enlarged view

No. HTMSOP8-A-Board-SD-1.0

HTMSOP-8 Test Board

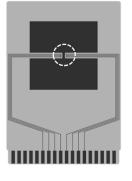
Item

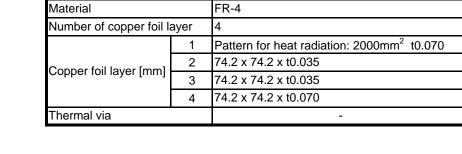
Size [mm]

🔵 IC Mount Area

Specification

(4) Board D



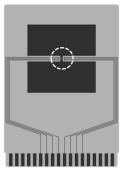


114.3 x 76.2 x t1.6



enlarged view

(5) Board E



Item		Specification
Size [mm]		114.3 x 76.2 x t1.6
Material		FR-4
Number of copper foil layer		4
	1	Pattern for heat radiation: 2000mm ² t0.070
Copper foil layer [mm]	2	74.2 x 74.2 x t0.035
	3	74.2 x 74.2 x t0.035
	4	74.2 x 74.2 x t0.070
Thermal via		Number: 4 Diameter: 0.3 mm



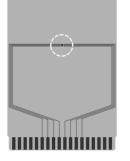
enlarged view

No. HTMSOP8-A-Board-SD-1.0

HSNT-8(2030) Test Board

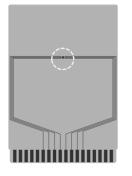
(1) Board A

🔵 IC Mount Area



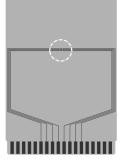
Item		Specification
Size [mm]		114.3 x 76.2 x t1.6
Material		FR-4
Number of copper foil layer		2
	1	Land pattern and wiring for testing: t0.070
Copper foil layer [mm]	2	-
Copper foir layer [mm]	3	-
	4	74.2 x 74.2 x t0.070
Thermal via		-

(2) Board B



Item		Specification
Size [mm]		114.3 x 76.2 x t1.6
Material		FR-4
Number of copper foil layer		4
Copper foil layer [mm]	1	Land pattern and wiring for testing: t0.070
	2	74.2 x 74.2 x t0.035
	3	74.2 x 74.2 x t0.035
	4	74.2 x 74.2 x t0.070
Thermal via		-

(3) Board C



Item		Specification
Size [mm]		114.3 x 76.2 x t1.6
Material		FR-4
Number of copper foil la	ayer	4
	1	Land pattern and wiring for testing: t0.070
Copper foil layer [mm]	2	74.2 x 74.2 x t0.035
	3	74.2 x 74.2 x t0.035
	4	74.2 x 74.2 x t0.070
Thermal via		Number: 4 Diameter: 0.3 mm

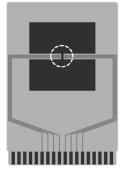
enlarged view

No. HSNT8-A-Board-SD-2.0

HSNT-8(2030) Test Board

🔵 IC Mount Area

(4) Board D

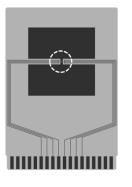


Item		Specification
Size [mm]		114.3 x 76.2 x t1.6
Material		FR-4
Number of copper foil layer		4
	1	Pattern for heat radiation: 2000mm ² t0.070
Copper foil layer [mm]	2	74.2 x 74.2 x t0.035
	3	74.2 x 74.2 x t0.035
	4	74.2 x 74.2 x t0.070
Thermal via		-



enlarged view

(5) Board E

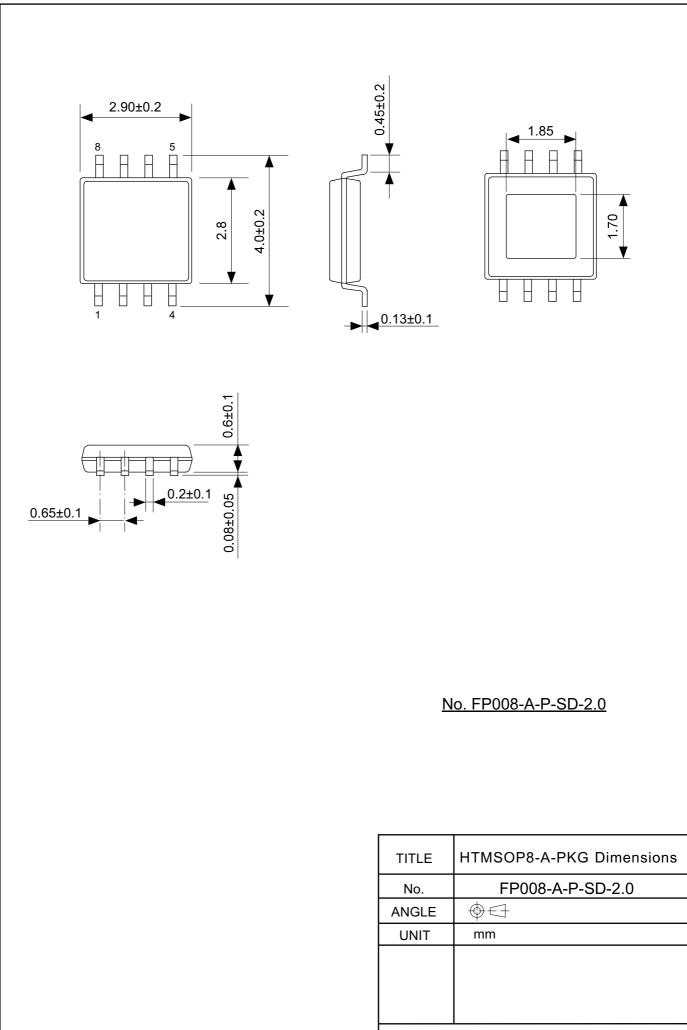




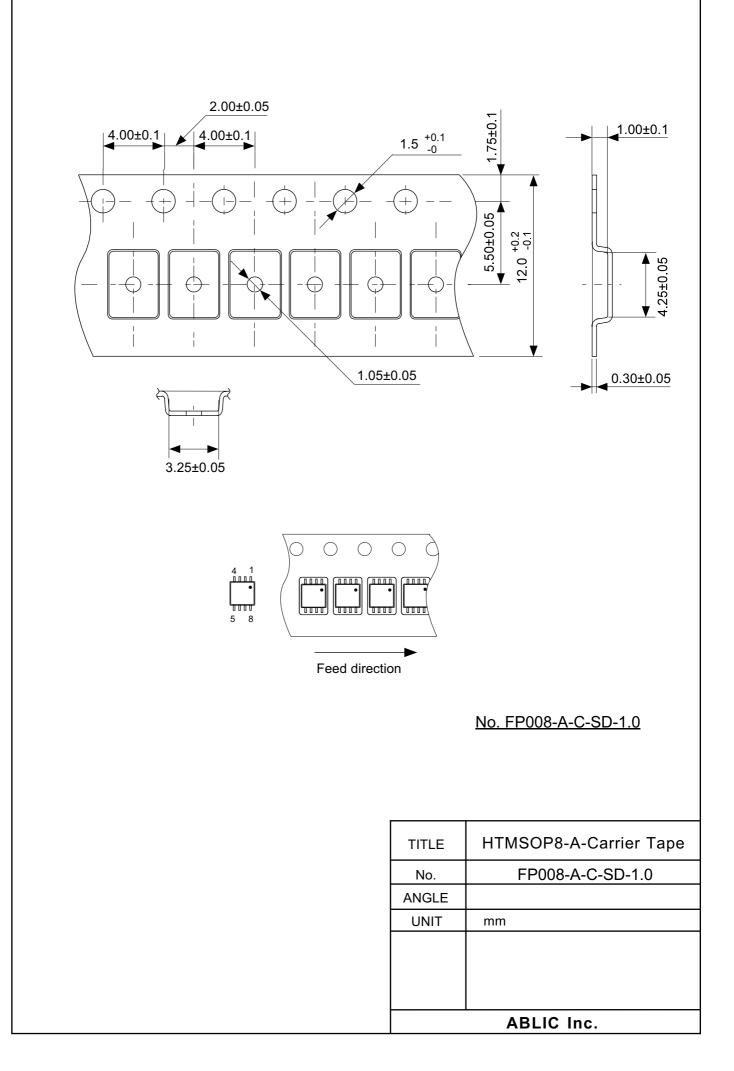
enlarged view

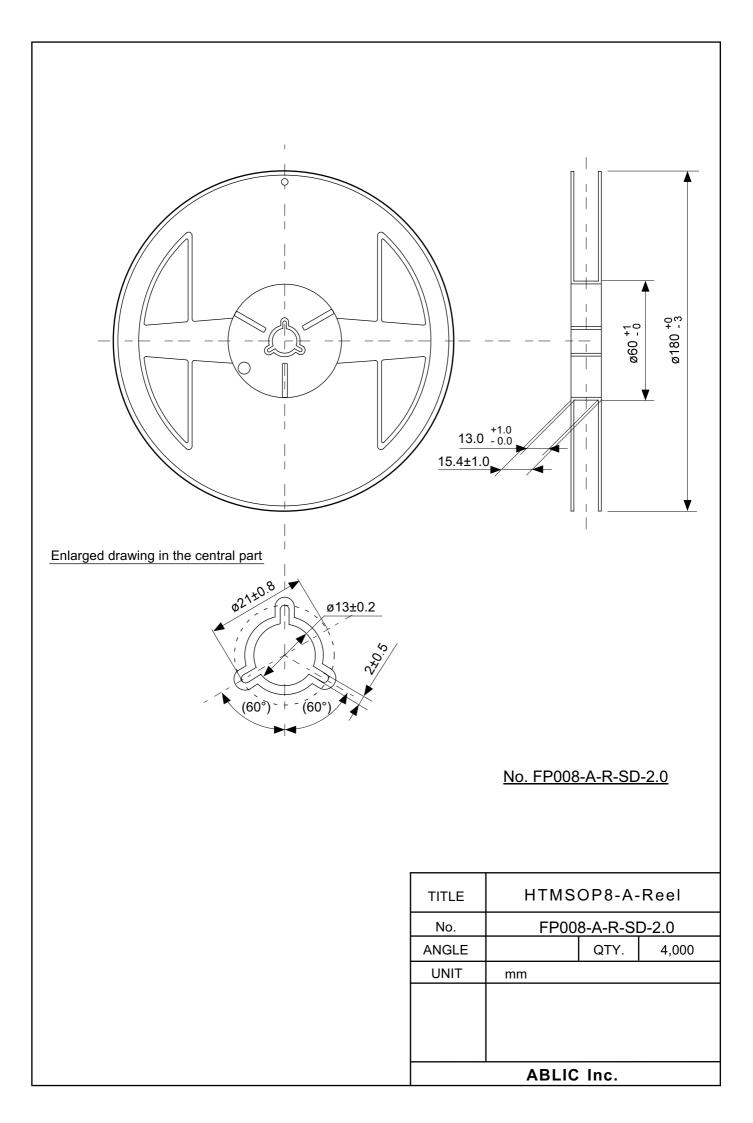
Item		Specification
Size [mm]		114.3 x 76.2 x t1.6
Material		FR-4
Number of copper foil la	ayer	4
	1	Pattern for heat radiation: 2000mm ² t0.070
Copper foil layer [mm]	2	74.2 x 74.2 x t0.035
	3	74.2 x 74.2 x t0.035
	4	74.2 x 74.2 x t0.070
Thermal via		Number: 4 Diameter: 0.3 mm

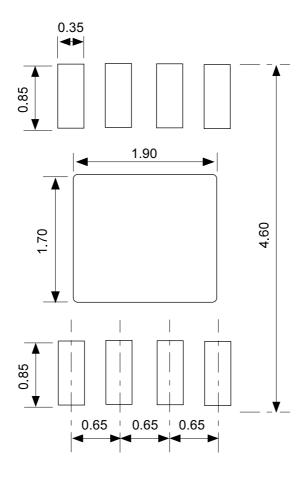
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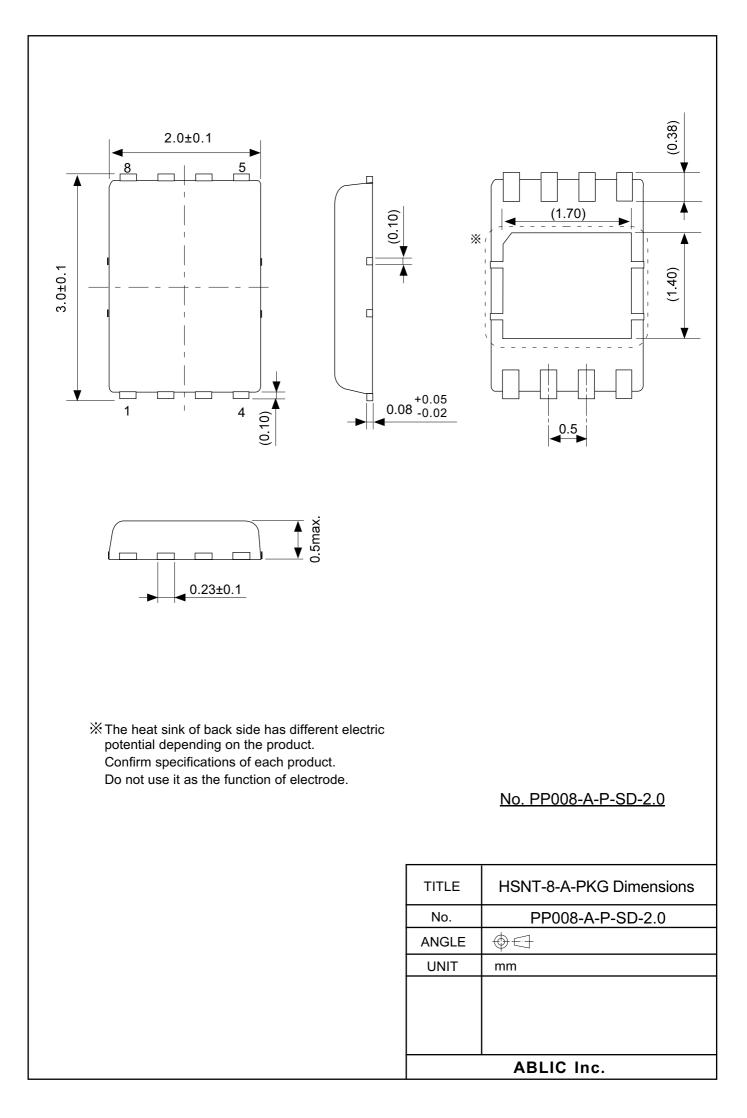


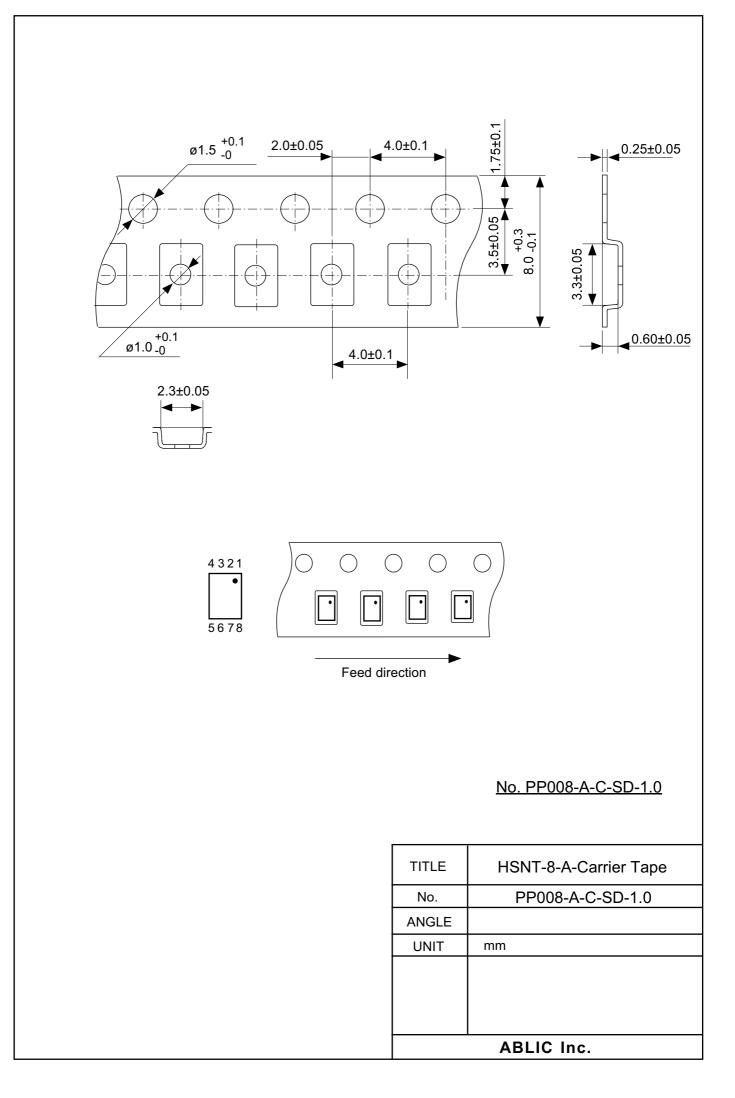


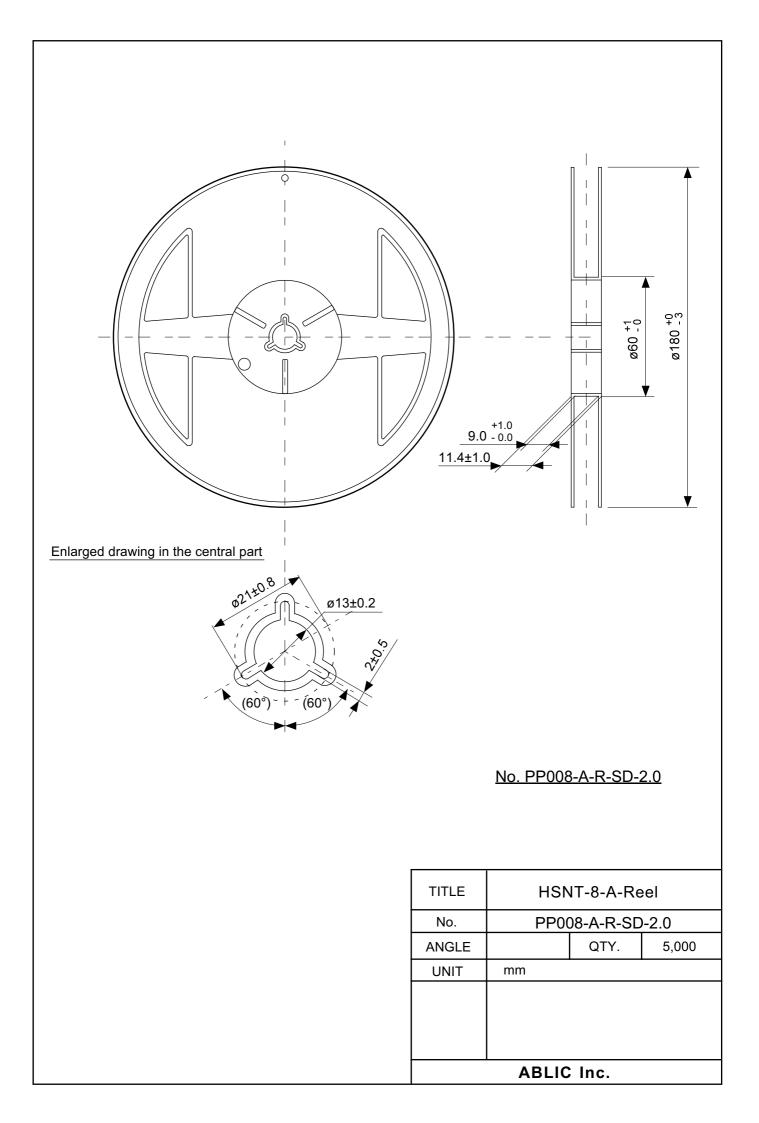


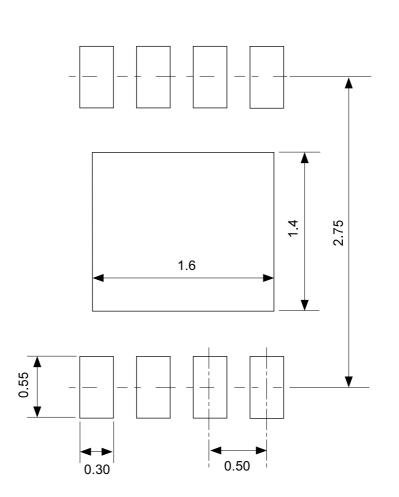
No. FP008-A-L-SD-2.0

TITLE	HTMSOP8-A -Land Recommendation		
No.	FP008-A-L-SD-2.0		
ANGLE			
UNIT	mm		
ABLIC Inc.			









No. PP008-A-L-SD-1.0

TITLE	HSNT-8-A -Land Recommendation
No.	PP008-A-L-SD-1.0
ANGLE	
UNIT	mm
ABLIC Inc.	

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